



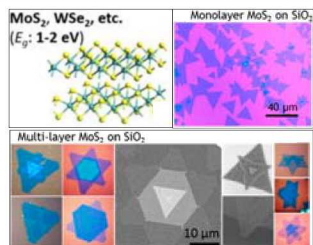
Electronic band alignment of few-layer transition metal dichalcogenides on SiO₂

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Introduction



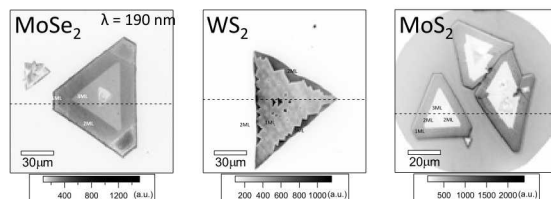
2D layers of transition metal dichalcogenides (TMDs) are a proposed alternative to conventional semiconductors for constructing junctions in next-generation devices. MoS₂, WS₂, MoSe₂, model TMDs, show favorable properties for electronic and optoelectronic applications including high on-off ratios, high photoluminescence quantum efficiency, high photogain and photoresponse. The open experimental questions we address in this study, relevant for device performance and considerations, include:

- Evolution of work function, ϕ , with layer number
- Doping of TMD on SiO₂
- The band alignment among MoS₂, WS₂, & MoSe₂

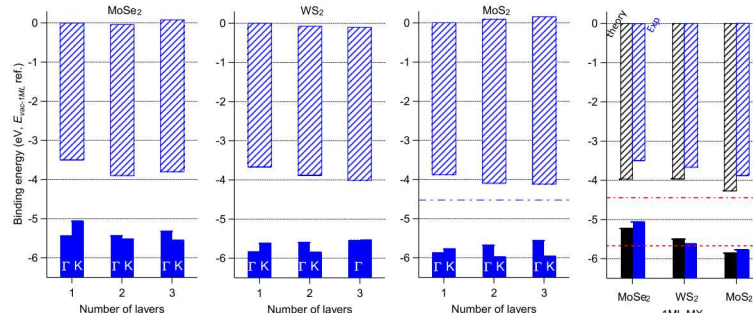
So far, environmental effects (chemical modification due to exposure, substrate interactions) have prevented a clear, systematic understanding of these properties via experiment.

Band alignment of MoS₂, WS₂, & MoSe₂: a complete picture

The ionization energy displays a progressive decrease from MoS₂, to WS₂, to MoSe₂, in agreement with reported density functional theory calculations. We deduce that a heterojunction comprising any of the three TMD monolayers would form a staggered (type-II) band alignment in the absence of the interlayer coupling.



PEEM intensity images of MoSe₂, WS₂, and MoS₂ acquired at 0.1 eV below E_{vac} of the 1 ML area. Higher photoemission intensity is shown as darker gray.

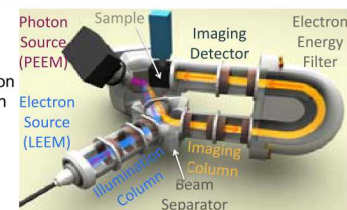


Band edge diagrams of as a function of their thicknesses. The hashed boxes represent the conduction bands, and the solid boxes represent the valence bands. The right figure compares experimentally determined band diagrams to those of DFT modeling.

Local Photoemission Measurement using Spectroscopic PEEM

Spectroscopic PEEM features:

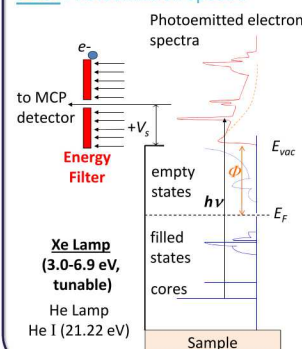
- Spatial resolution: 10 - 15 nm
- Spectral resolution: 200 meV
- Electron/Photon/Thermal excitation
- Real-time imaging of processes in situ



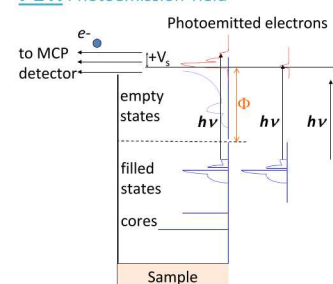
Two modes of photoemission measurement:

- Fixed energy, local PES (laser) $\lambda = 213$ nm, $h\nu = 5.82$ eV
- Variable energy, local PEY

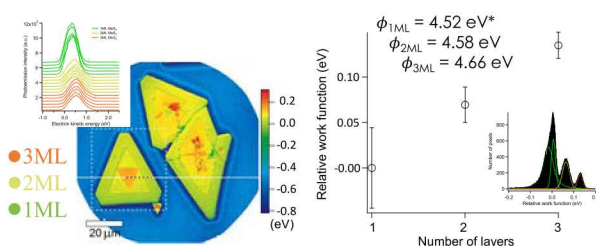
PES: Photoemission Spectra



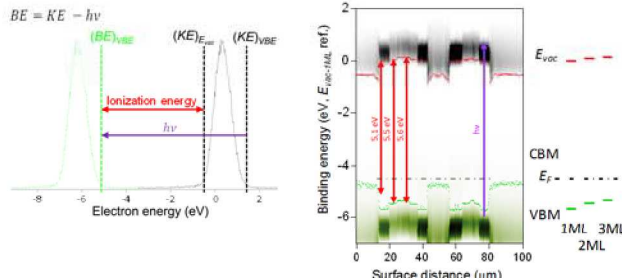
PEY: Photoemission Yield



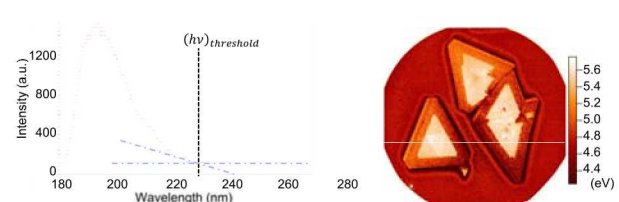
PES & PEY measurements of layer-dependent work function & ionization energy for MoS₂



Relative vacuum level (E_{vac}) and valence band edge increase with each additional layer, establishing a layer-dependent surface potential and work function increase with increasing layer number.



We obtain the binding energy of the valence band edge relative to the vacuum level and construct an experimental band diagram that shows the local ionization energy measured with PES.



Despite agreement in PES and PEY results for I_{3ML} , there are disparities for I_{1ML} and I_{2ML} (see red bidirectional arrows in the experimental band diagram). Considering the mechanisms that differ between the two modes of photoemission measurement, we rely on our PES results for a more accurate determination of ionization energy.

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